

## N-Channel 30-V (D-S) MOSFET

### **Description**

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low RDS(on) and to ensure minimal power loss and heat dissipation.

Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, and PCMCIA cards, cellular and cordless telephones.



- Low rDS(on) provides higher efficiency and extends battery life
- Low thermal impedance copper lead frame DFN3x3 saves board space
- Fast switching speed
- High performance trench technology
- RoHS compliant package

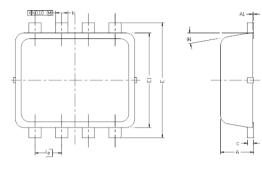
Package type: DFN 3X3

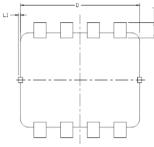
### **Packing & Order Information**

3,000/Reel



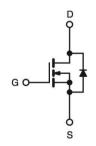


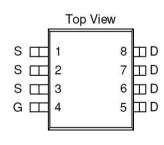




DIM.	MILLIMETERS			INCHES			
	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.700	0.800	0.900	0.028	0.0315	0.0354	
A1	0.000	-	0.050	0.000	-	0.002	
b	0.240	0.300	0.350	0.009	0.012	0.014	
С	0.080	0.152	0.250	0.003	0.006	0.010	
DIM.	2.90 BSC			0.114 BSC			
Е	2.80 BSC 0.110 BSC				C		
E1	2.30 BSC			0.091 BSC			
е	0.65 BSC			0.026 BSC			
L	0.200	0.375	0.450	0.008	0.0148	0.0177	
L1	0.000	-	0.100	0.000	-	0.004	
θ1	0.000	10.000	12.000	0.000	10.000	12.000	

### Graphic symbol





### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (T <sub>A</sub> =25°C Unless Otherwise Noted)				
Symbol	Parameter	Value	Unit	
$V_{DS}$	Drain-Source Voltage	30	V	
V <sub>GS</sub>	Gate-Source Voltage	±20	V	
T_	Drain Current -Continuous a (T <sub>A</sub> =25 °C)	±19	A	
$I_D$	Drain Current -Continuous a (T <sub>A</sub> = 70 °C)	±16	A	
$I_{DM}$	Pulsed Drain Current <sup>b</sup>	±40	A	
$P_D$	Total Power Dissipation <sup>a</sup> (T <sub>A</sub> =25°C)	3.5	W	
	Total Power Dissipation <sup>a</sup> (T <sub>A</sub> =70°C)	2	W	



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Absolute Maximum Ratings (T <sub>A</sub> =25°C Unless Otherwise Noted)					
Symbol	Parameter	Value	Unit		
Is	Continuous Source Current (Diode Conduction) <sup>a</sup>	2	A		
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C		

Thermal Data					
Symbol	Parameter Max.				
$R_{\theta JC}$	aximum Junction-to-Case <sup>a</sup> (t<=5 sec ) 35		°C/W		
$R_{\theta JA}$	Maximum Junction-to- Ambient <sup>a</sup> ( t<=5 sec ) 50		C/W		

#### Note:

- 1. Surface Mounted on 1"x1" FR4 Board.
- 2. Pulse width limited by maximum junction temperature.

Static					
Symbol	Test Conditions	Min	Тур.	Max.	Units
$V_{SD}$	$V_{GS} = 0 \text{ V}$ , $I_S = 2.3 \text{ A}$		0.7		V
V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	1		3	V
IDSS	$V_{DS} = 24 \ V$ , $V_{GS} = 0 \ V$ $V_{DS} = 24 \ V$ , $V_{GS} = 0 \ V$ , $T_{j=} 55^{\circ}C$			1 25	uA
Igss	$V_{GS}=20\ V\ ,\ V_{DS}=0$			±100	nA
I <sub>D(ON)</sub>	$V_{DS} = 5 V$ , $V_{GS} = 10 V$	20			A
R <sub>DS</sub> (ON)	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$			6.9 9.8	mΩ
G <sub>FS</sub> *1	V <sub>DS</sub> = 15 V,I <sub>D</sub> = 10 A		40		S

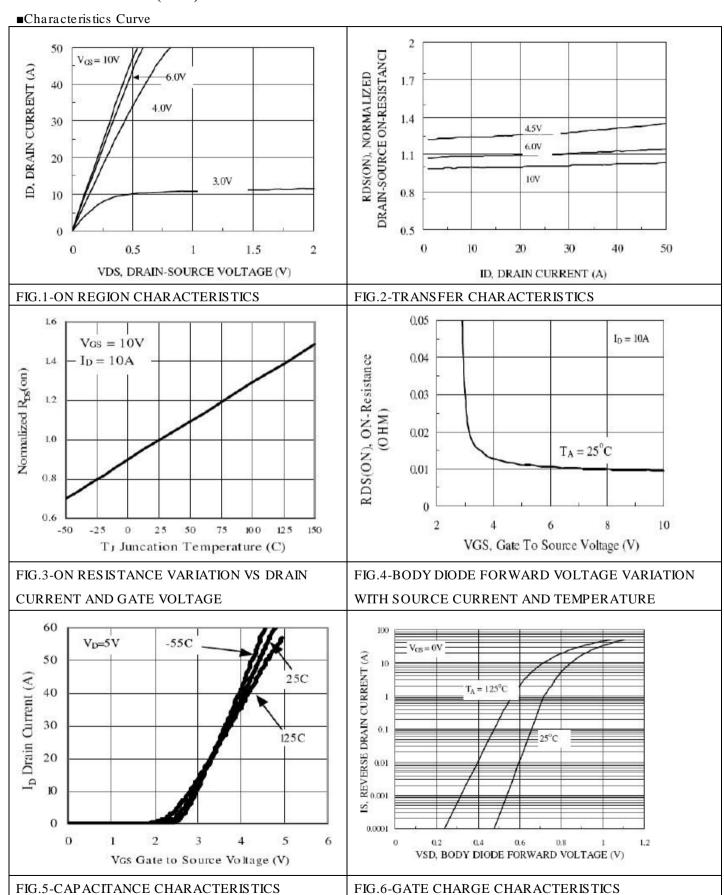
Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units
$C_{ISS}$	Input Capacitance			1302		pF
Coss	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		423		pF
$C_{RSS}$	Reverse Transfer Capacitance	1 – 1.0WHZ		171		pF
$Q_g$	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_D = 10 \text{ A},$ $V_{GS} = 4.5 \text{ V}$		11		nC
$Q_{gs}$	Gate-Source Charge			6		nC
$Q_{\rm gd}$	Gate-Drain Charge			4		nC
$t_{d(on)}$	Turn-On Dalay Time	$V_{DD} = 25 \text{ V}, \ I_D = 1 \text{ A},$ $R_L = 25 \ \Omega, \ V_{GEN} = 10 \text{ V}$		10		ns
t <sub>r</sub>	Rise Time			5		ns
$t_{ m d(off)}$	Turn-Off Dalay Time			22		ns
tf	Fall Time			4		ns

#### Notes

- a. Pulse test: PW  $\leq$  300us duty cycle  $\leq$  2%.
- b. Guaranteed by design, not subject to production testing.



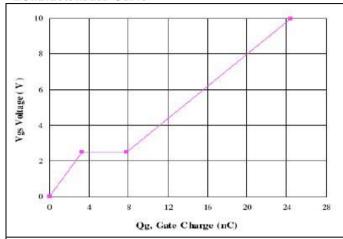
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#### ■Characteristics Curve



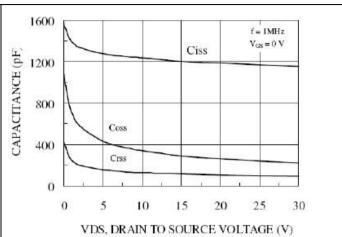


FIG.7-BREAKDOWN VOLTAGE VARIATION VS TEMPERATURE

2.4
2.2
1.8
1.6
1.4
1.2
1.50 -25 0 25 50 75 100 125 150 175

TA, AMBIENT TEMPERATURE (°C)

FIG.8-ON-RESISTANCE VARIATION VS TEMPERATURE

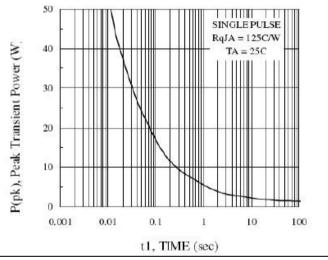
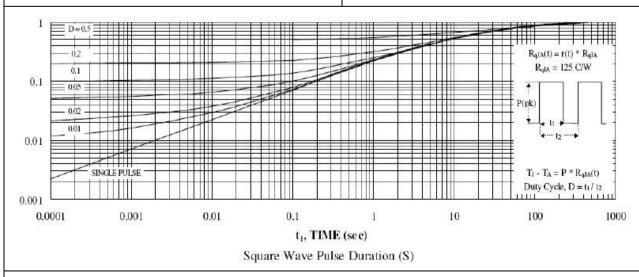


FIG.9-MAXIMUM SAFE OPERATING AREA

 $\label{eq:fig.10-maximum} \textbf{FIG.10-MAXIMUM DRAIN CURRENT VS CASE} \\ \textbf{TEMPERATURE}$ 





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